

<b>Notice of References Cited</b>	Application/Control No. 09/932,531	Applicant(s)/Patent Under Reexamination AKERS	
	Examiner Rick Palabrica	Art Unit 3641	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-3,662,882	05-1972	Obermayer, Arthur S.	378/45
	B	US-2002/0103410 A1	08-2002	Munro et al.	600/3
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Gedcke, ORTEC AN 59, "How Counting Statistics Controls Detection Limits and Peak Precision", from <a href="http://www.ortec-online.com/application-notes/an59.pdf">http://www.ortec-online.com/application-notes/an59.pdf</a> , downloaded 6/26/04.
	V	Simon Fraser University Radiation Safety Office, "Radiation Counting STatistics," <a href="http://www.sfu.ca/radiation-safety/ststistics.html">http://www.sfu.ca/radiation-safety/ststistics.html</a> , downloaded 6/26/04.
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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